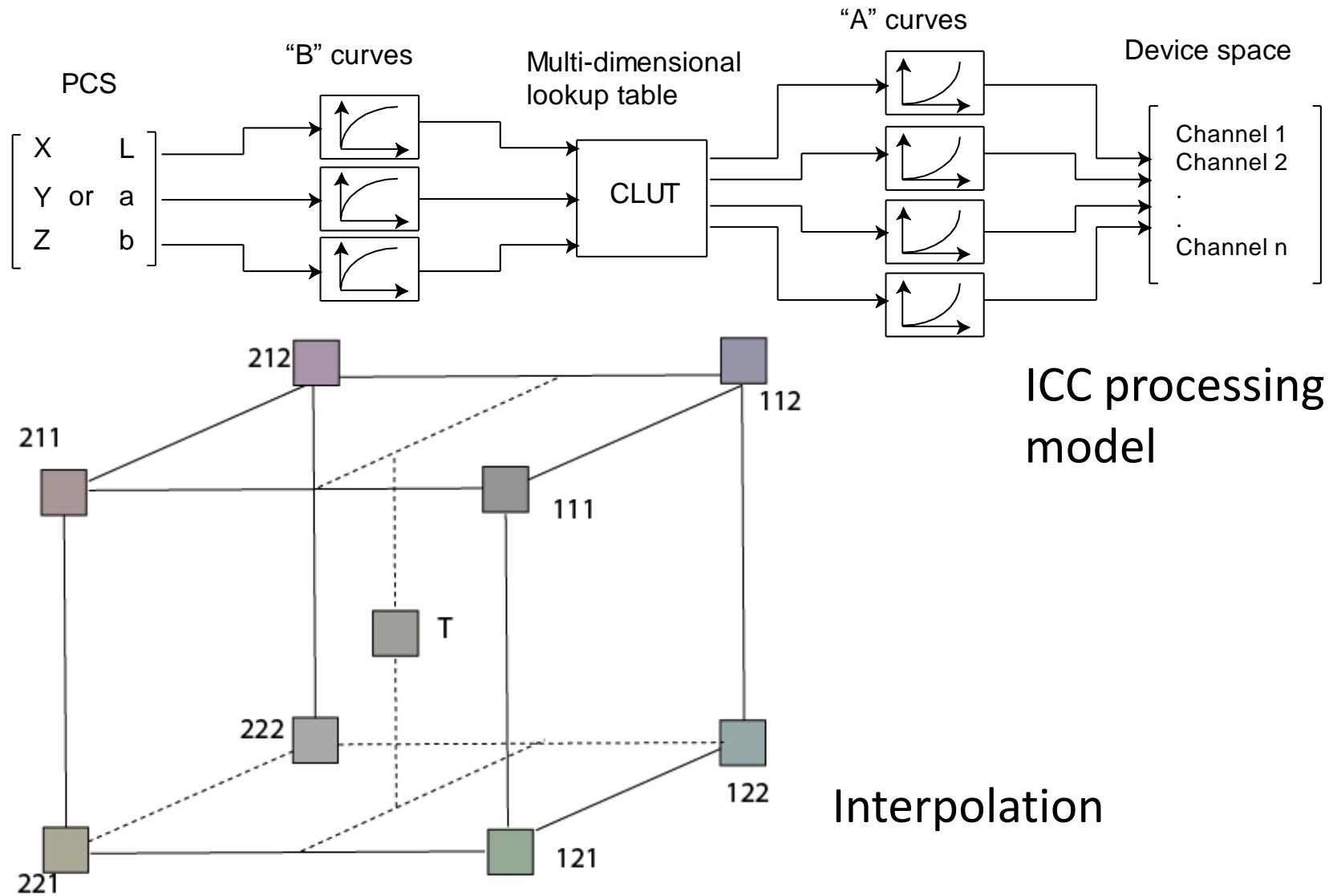


# Approaches to linearization in ICC profiles

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# Introduction

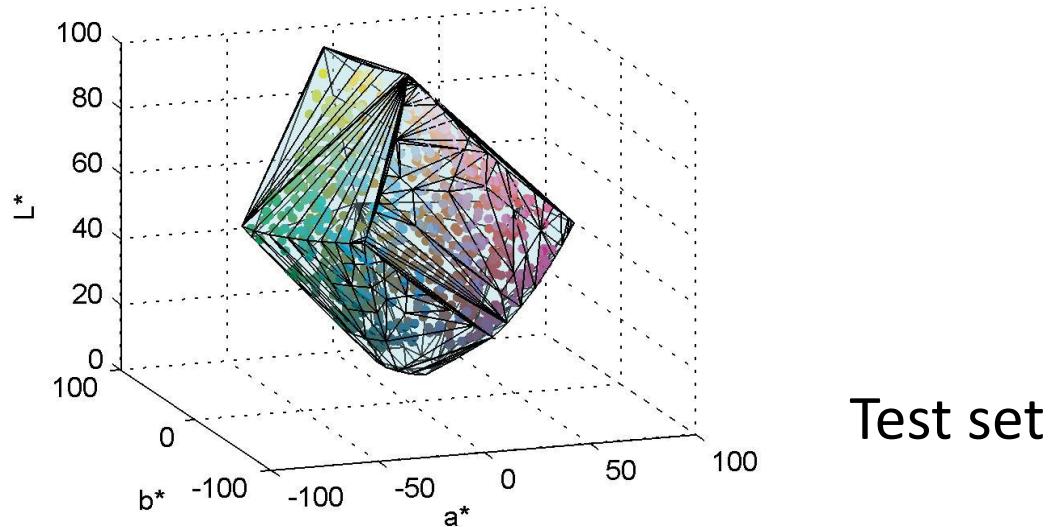


# Literature overview

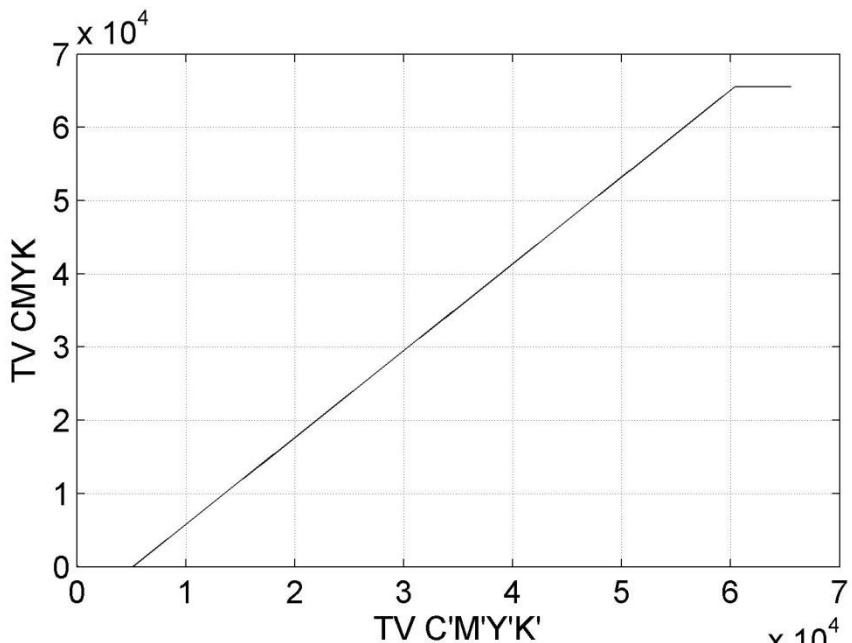
- Profiles
  - Zeng, 2002.
    - PCS choice
    - 3D LUT type and size
    - 1D LUT use and size
- Linearization approaches
  - Noyes et al. 2000.
    - minimizing CIE  $\Delta E$
    - with respect to CIE  $L^*$  and  $b^*$

# Problem statement and methodology

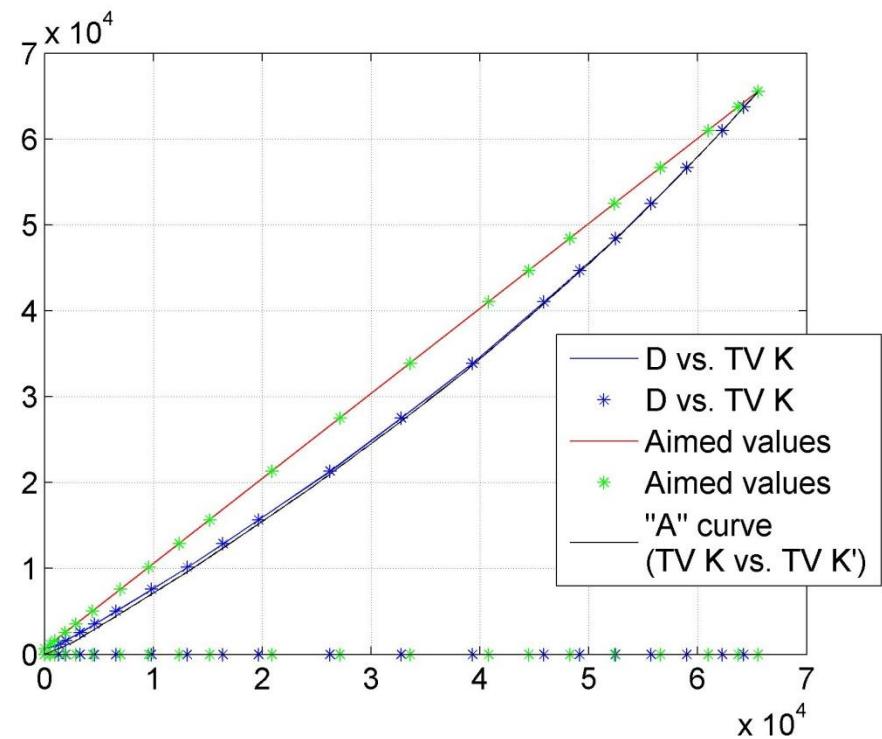
- To what extent linearization affects accuracy of a standard profile?
- ISO Coated v2
- Polyharmonic spline model



# Problem statement and methodology

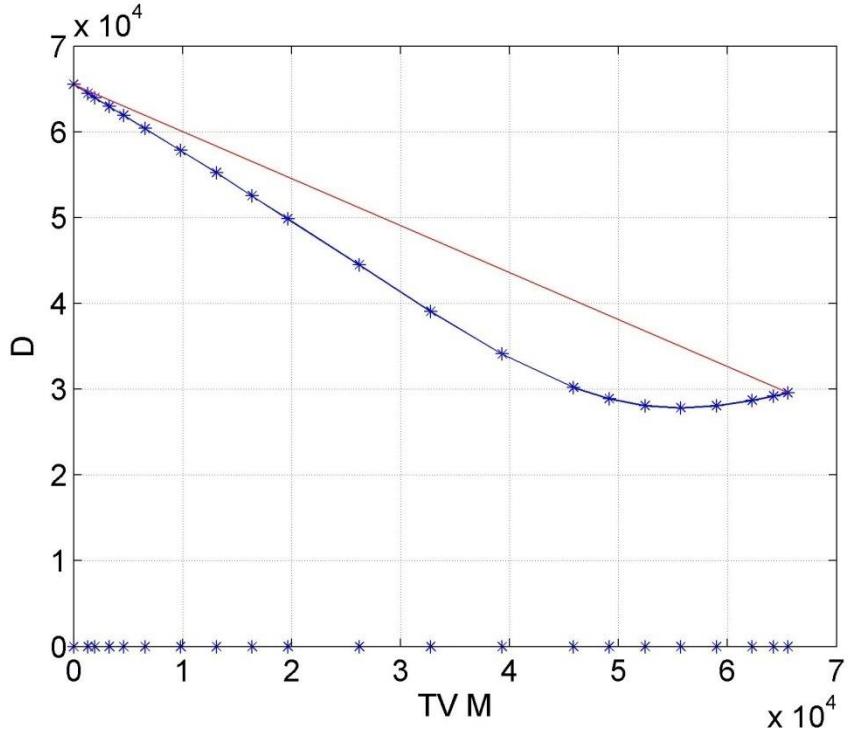


Generic "A curve"

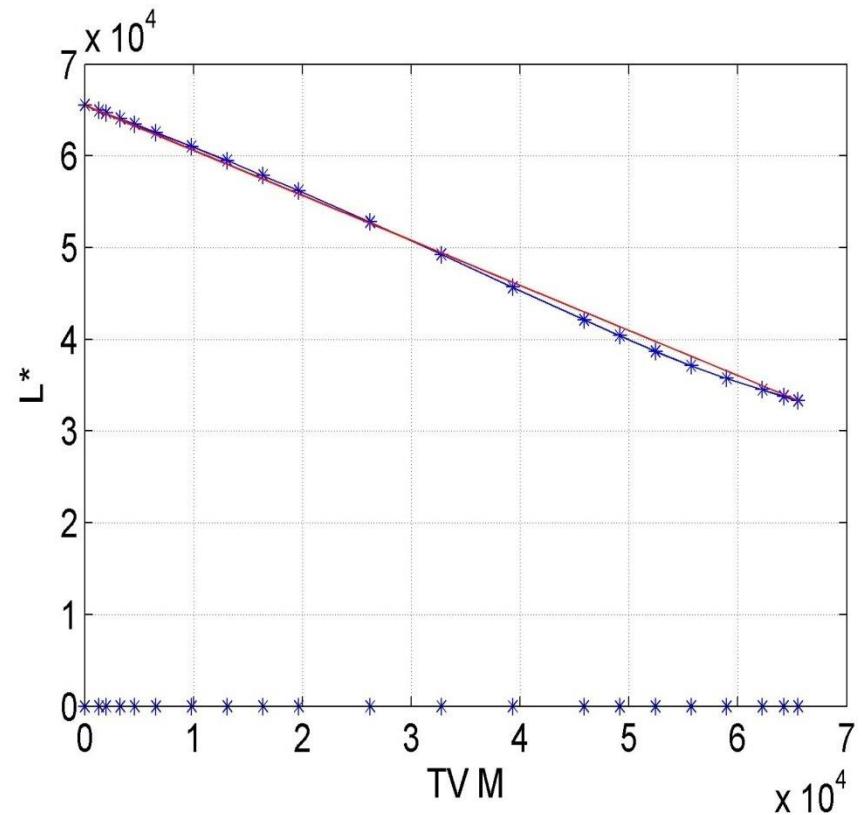


$D$  vs.  $TV\ K$  and linearization  
"A" curve

# Results



Magenta ink  
linearization to D

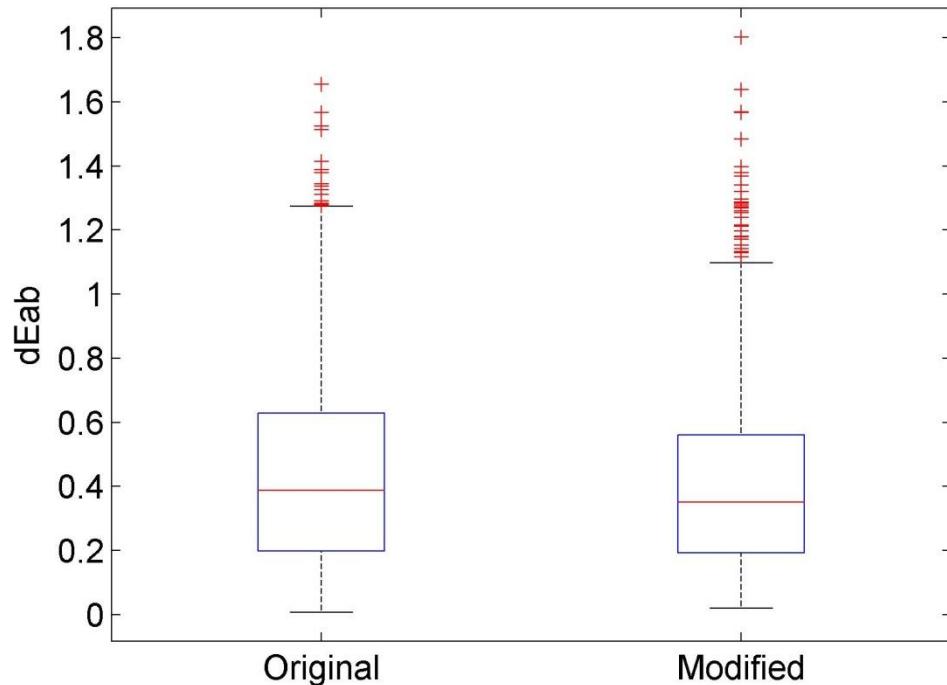


Magenta ink linearization  
to  $L^*$

# Results

## Numerical evaluation

<b>N = 918</b>	<b>Min <math>\Delta E</math></b>	<b>Mean <math>\Delta E</math></b>	<b>Median <math>\Delta E</math></b>	<b>Max <math>\Delta E</math></b>
Original	0,01	0,45	0,39	1,66
Modified	0,02	0,42	0,35	1,80



Boxplots of error distributions

# Conclusions

- Linearization minimizing CIE  $\Delta E$  can be problematic
- Standard 33x33x33 CLUT size provides sufficient accuracy
- Linearization does not improve accuracy significantly on standard 33x33x33 CLUT size